Search Notes			

Application/Control No.	. Applicant(s)/Patent und Reexamination	er
10/603,313	LU ET AL.	
Examiner	Art Unit	
Christina Bradley	1654	

SEARCHED			
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INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH)
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sequence search of SEQ ID NO:14 submitted to STIC	7/27/2006	STIC
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